

Notice of References Cited

Application/Control No.

10/553,286

Applicant(s)/Patent Under
Reexamination
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Examiner

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Art Unit

4153

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,228,806	10-1980	Lidow, Derek	600/544
*	B	US-2002/0080035	06-2002	Youdenko, Konstantin	340/573.1
*	C	US-6,791,462	09-2004	Choi, Sang J.	340/575
*	D	US-2005/0154330	07-2005	Loree, Leonor F. IV	600/595
*	E	US-2006/0106275	05-2006	Raniere, Keith	600/026
*	F	US-2007/0083079	04-2007	Lee et al.	600/027
*	G	US-5,101,831	04-1992	Koyama et al.	600/500
*	H	US-5,928,133	07-1999	Halyak, George	600/26
*	I	US-6,928,031	08-2005	Kanevsky et al.	368/12
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 9116853 A1	11-1991	World Intellect	HEARNE, KEITH MELVYN	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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